

FDMS7672 N-Channel PowerTrench[®] MOSFET 30 V, 5.0 m Ω

Features

- Max $r_{DS(on)} = 5.0 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 19 \text{ A}$
- Max $r_{DS(on)} = 6.9 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 15 \text{ A}$
- Advanced Package and Silicon design for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery. Provides Schottky-like performance with minimum EMI in sync buck converter applications.
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

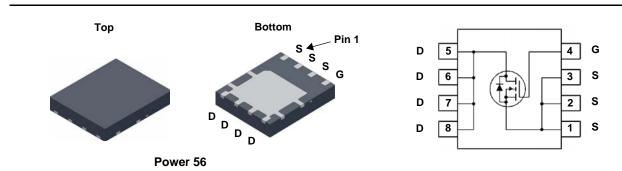


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$, fast switching speed and body diode reverse recovery performance.

Applications

- IMVP Vcore Switching for Notebook
- VRM Vcore Switching for Desktop and Server
- OringFET / Load Switch
- DC-DC Conversion



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			30	V	
V _{GS}	Gate to Source Voltage			±16	V	
	Drain Current -Continuous (Package limited)	T _C = 25 °C		28		
I _D	-Continuous (Silicon limited)	T _C = 25 °C		80	٨	
	-Continuous	T _A = 25 °C	(Note 1a)	19	Α	
	-Pulsed			90		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	72	mJ	
D	Power Dissipation	T _C = 25 °C		48	3 W	
P _D	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV	
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case		2.6	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7672	FDMS7672	Power 56	13 "	12 mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
, Off Chara	cteristics			,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		1
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		15		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current, Forward	$V_{GS} = 16 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	1.25	2.0	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		-7		mV/°C
-		V _{GS} = 10 V, I _D = 19 A		3.6	5.0	
r _{DS(on)} Static E	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 15 \text{ A}$		5.2	6.9	mΩ
		V_{GS} = 10 V, I_{D} = 19 A, T_{J} = 125 °C		4.9	6.8	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 19 A		64		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance			2225	2960	pF
C _{oss}	Output Capacitance	− V _{DS} = 15 V, V _{GS} = 0 V, _ f = 1 MHz		685	910	pF
C _{rss}	Reverse Transfer Capacitance			90	130	pF
Rg	Gate Resistance			0.5		Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			13	23	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 19 A,		5	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		25	40	ns
t _f	Fall Time	1		4	10	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V		31	44	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} \text{ V}_{DD} = 15 \text{ V},$		14	19	nC
Q _{gs}	Gate to Source Charge	I _D = 19 A		7.6		nC
Q _{gd}	Gate to Drain "Miller" Charge			3.7		nC
Drain-Sou	urce Diode Characteristics					
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)		0.7	1.2	v
▼ SD		$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 19 \text{ A}$ (Note 2)		0.8	1.3	v
t _{rr}	Reverse Recovery Time	– I _F = 19 A, di/dt = 100 A/μs		32	51	ns
Q _{rr}	Reverse Recovery Charge	$F = 13 \text{ A}, \text{ u/ut} = 100 \text{ A/}\mu\text{s}$		14	24	nC
t _{rr}	Reverse Recovery Time	– I _F = 19 A, di/dt = 300 A/μs		26	42	ns

Q_{rr} Notes:

Notes: 1. R_{0,A} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



Reverse Recovery Charge

a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.

b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

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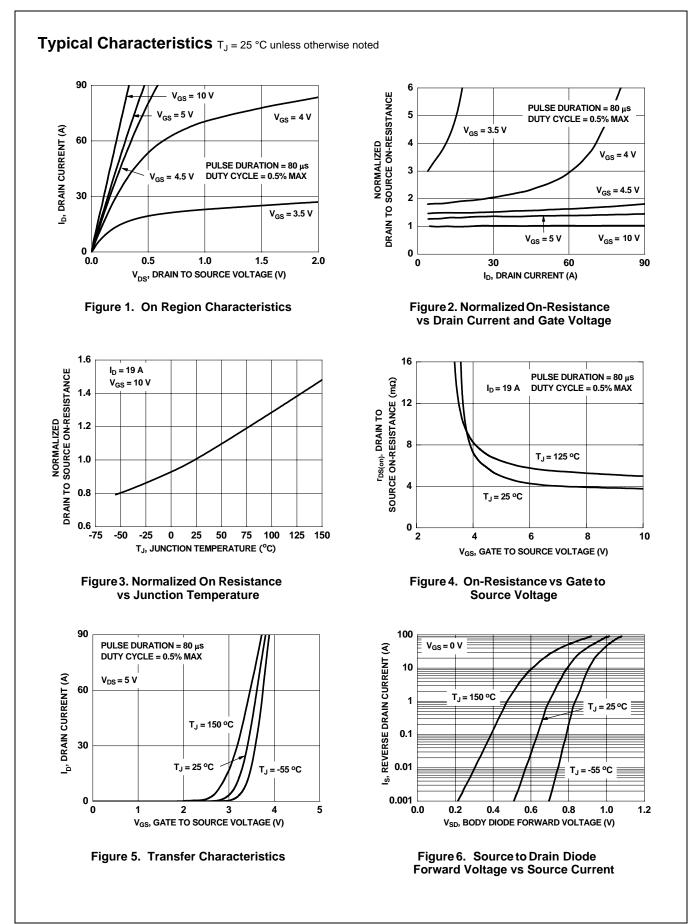
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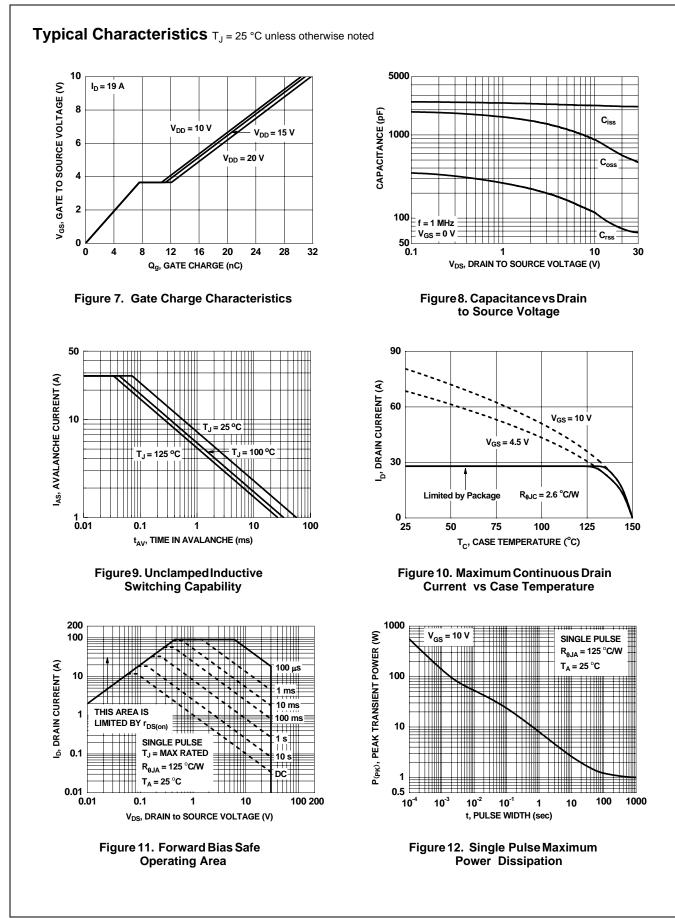
nC

2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

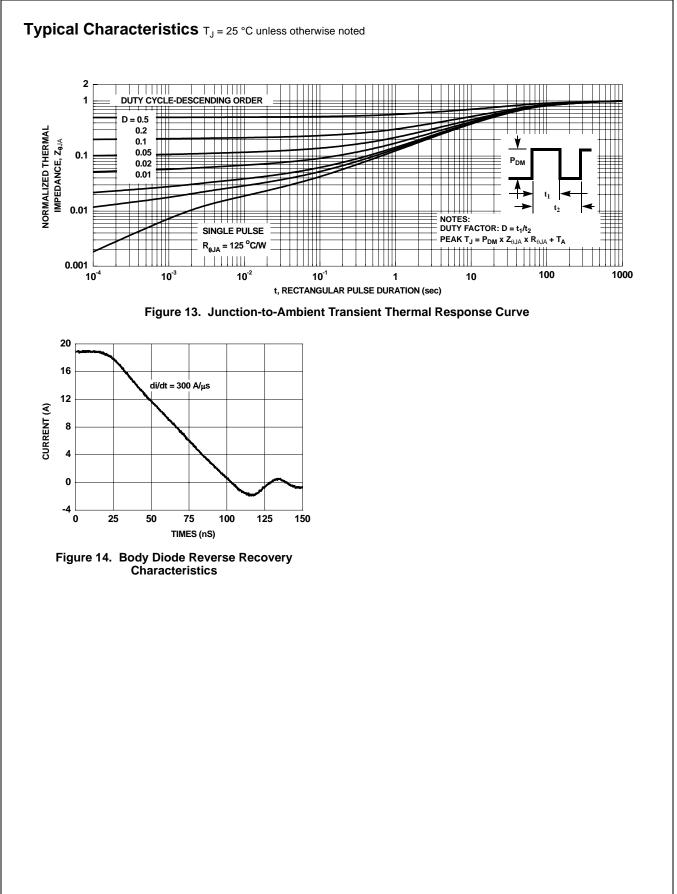
3. E_{AS} of 72 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 12 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 17 A.



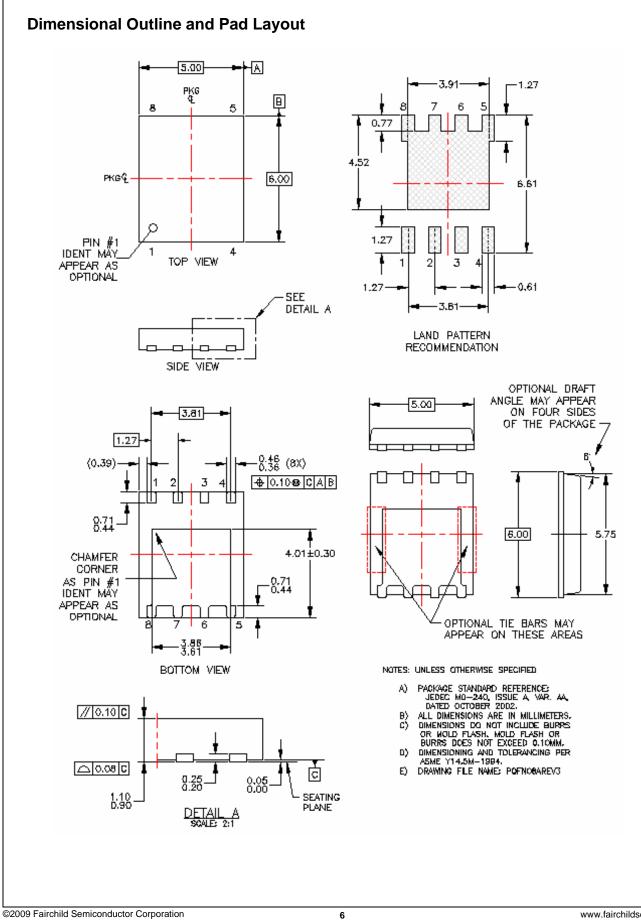




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